

Notice of References Cited	Application/Control No. 10/759,057	Applicant(s)/Patent Under Reexamination WANG, CHIN YANG	
	Examiner Benny Q. Tieu	Art Unit 2614	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,134,421	10-2000	Lee et al.	455/575.9
*	B	US-6,647,248	11-2003	Ortscheid et al.	224/255
*	C	US-2004/0086112	05-2004	Hilger et al.	379/455
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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